

#### **N-Channel MOSFET**

## **General Description**

The WSD2090DN56 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD2090DN56 meet the RoHS and Green Product requirement 100%  $E_{AS}$  guaranteed with full function reliability approved.

## **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>		
20V	2.8mΩ	80A		

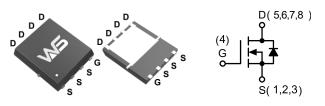
### Applications

- Switch
- Power System
- Load Switch

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% E<sub>AS</sub> Guaranteed
- Green Device Available

## **DFN5X6-8L Pin Configuration**



-55 to 175

#### Symbol Parameter Units Rating V<sub>DSS</sub> **Drain-Source Voltage** 20 V $V_{GSS}$ Gate-Source Voltage ±12 $I_D@T_C=25^{\circ}C$ Continuous Drain Current, V<sub>GS</sub> @ 10V<sup>1</sup> 80 I<sub>D</sub>@T<sub>C</sub>=100°C Continuous Drain Current, V<sub>GS</sub> @ 10V<sup>1</sup> 59 А Pulsed Drain Current<sup>1</sup> 360 $I_{DM}$ Single Pulse Avalanche Energy<sup>2</sup> 110 mJ $\mathsf{E}_{\mathsf{AS}}$ 81 W $P_D$ **Power Dissipation** Storage Temperature Range -55 to 175 T<sub>STG</sub> °C

**Operating Junction Temperature Range** 

## **Absolute Maximum Ratings** (T<sub>C</sub>=25°C, Unless Otherwise Noted)

### **Thermal Data**

 $\mathsf{T}_\mathsf{J}$ 

Symbol	Parameter		Max.	Units
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient <sup>1</sup>		65	°C/W
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case <sup>1</sup>		4	C/W



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## Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250µA	20			V
$\Delta BV_{DSS}/\Delta T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C, I <sub>D</sub> =1mA		-0.018		V/°C
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=250\mu A$	0.5	0.8	1.3	V
D	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =30A		2.8	4.0	mΩ
R <sub>DS(ON)</sub>		V <sub>GS</sub> =2.5V , I <sub>D</sub> =20A		4.0	6.0	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V , V <sub>GS</sub> =0V			1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{GS}$ =±10V , $V_{DS}$ =0V			±100	nA
Qg	Total Gate Charge	_ V <sub>GS</sub> =4.5V,V <sub>DS</sub> =10V, _ I <sub>D</sub> =30A		11.5		nC
Q <sub>gs</sub>	Gate-Source Charge			1.73		
Q <sub>gd</sub>	Gate-Drain Charge			3.1		
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>GS</sub> =4.5V,V <sub>DS</sub> =10V, I <sub>D</sub> =30A,R <sub>GEN</sub> =1.8Ω		9.7		
T <sub>r</sub>	Turn-On Rise Time			37		
T <sub>d(off)</sub>	Turn-Off Delay Time			63		- ns
T <sub>f</sub>	Turn-Off Fall Time			52		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =10V , V <sub>GS</sub> =0V , f = 1.0MHz		4260		
C <sub>oss</sub>	Output Capacitance			510		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			480		

### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =7.6A,V <sub>GS</sub> =0V			1.2	V

Note:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width  $\leq 300 \mu s$  , duty cycle  $\leq 2\%$ 

3. The power dissipation is limited by 150°C junction temperature.

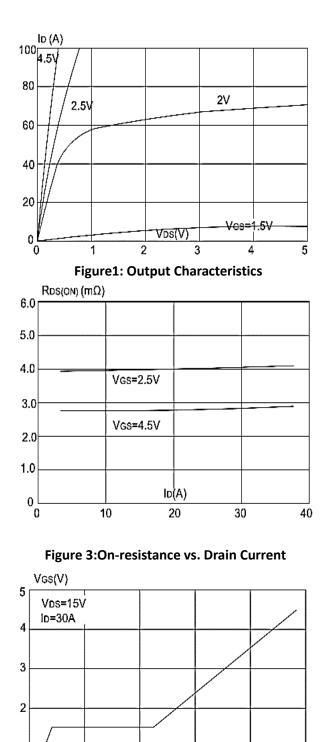
4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

5.  $E_{AS}$  condition:  $T_J {=} 25^\circ C, \ V_{DD} {=} 15 V, \ V_G {=} 4.5 V, \ R_G {=} 25 \Omega, \ L {=} 0.5 mH, \ I_{AS} {=} 21 A$ 



**N-Channel MOSFET** 

## **Typical Characteristics**



Qg(nC)

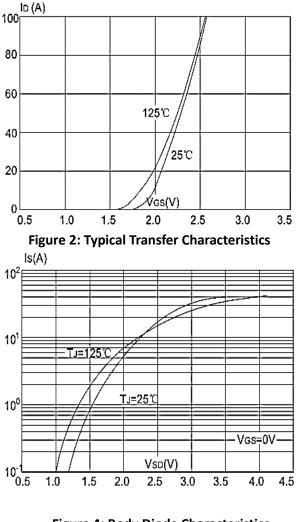
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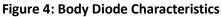
**Figure 5: Gate Charge Characteristics** 

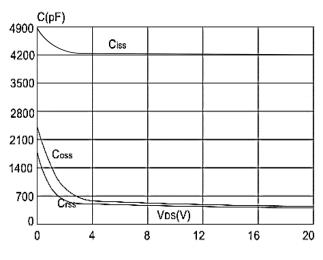
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50

20









10

1

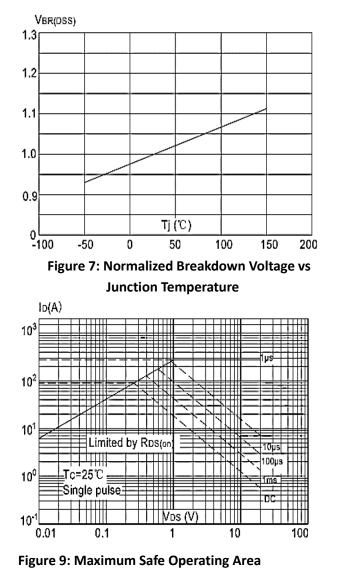
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0



**N-Channel MOSFET** 

## **Typical Characteristics (Cont.)**



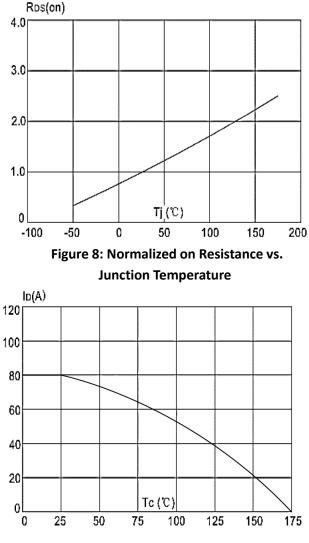
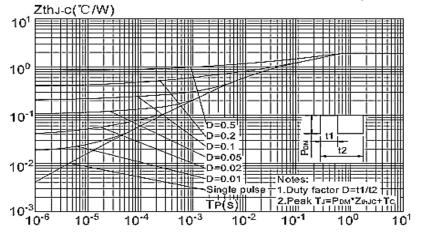
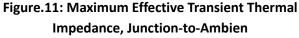


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

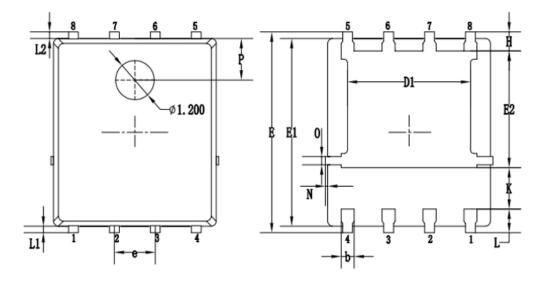


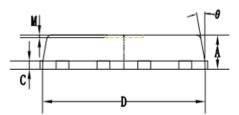




N-Channel MOSFET

## **Packaging information**





		MILLIMETERS				
SYMBOLS	MIN.	NOM.	MAX.			
A	0.90	1.05	1.20			
b	0.35	0.40	0.50			
С	0.20	0.25	0.35			
D	4.90	5.05	5.20			
D1	3.72	3.82	3.92			
E	6.00	6.15	6.30			
E1	5.60	5.75	5.90			
E2	3.47	3.57	3.67			
е		1.27 BSC.				
Н	0.48	0.58	0.68			
К	1.17	1.27	1.37			
L	0.64	0.74	0.84			
L1/L2		0.20 REF.				
θ	8°	10°	12°			
М		0.08 REF.				
N	0	-	0.15			
0		0.25 REF.				
Р		1.28 REF.				



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